Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/824,720	BJORKLUND ET AL.	
Examiner	Art Unit	
Tam M. Nguyen	1764	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
585	640 809 638 639	2/14/2007	TN

INI	ERFERENC	E SEARCH	IED
Class	Subclass	Date	Examiner
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SEARC (INCLUDING SE	CH NOTES ARCH STRATEGY	)
	DATE	EXMR
inventors searched	2/14/2007	TN
EAST	2/14/2006	TN
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